

32 M-WORD BY 72-BIT SYNCHRONOUS DYNAMIC RAM MODULE

REGISTERED TYPE

Description

The MC-4532DA726 is a 33,554,432 words by 72 bits synchronous dynamic RAM module on which 18 pieces of 128 M SDRAM: μ PD45128441 are assembled.

This module provides high density and large quantities of memory in a small space without utilizing the surface-mounting technology on the printed circuit board.

Decoupling capacitors are mounted on power supply line for noise reduction.

Features

- 33,554,432 words by 72 bits organization (ECC type)
- Clock frequency and access time from CLK

Part number	/CAS latency	Clock frequency (MAX.)	Access time from CLK (MAX.)	Module type
MC-4532DA726EF-A80	CL = 3	125 MHz	6 ns	PC100 Registered DIMM Rev. 1.0 Compliant
	CL = 2	100 MHz	6 ns	
MC-4532DA726EF-A10	CL = 3	100 MHz	6 ns	
	CL = 2	77 MHz	7 ns	
MC-4532DA726EFB-A80	CL = 3	125 MHz	6 ns	PC100 Registered DIMM Rev. 1.2 Compliant
	CL = 2	100 MHz	6 ns	
MC-4532DA726EFB-A10	CL = 3	100 MHz	6 ns	
	CL = 2	77 MHz	7 ns	

- Fully Synchronous Dynamic RAM, with all signals referenced to a positive clock edge
- Pulsed interface
- Possible to assert random column address in every cycle
- Quad internal banks controlled by BA0 and BA1 (Bank Select)
- Programmable burst-length (1, 2, 4, 8 and Full Page)
- Programmable wrap sequence (Sequential/ Interleave)
- Programmable /CAS latency (2, 3)
- Automatic precharge and controlled precharge
- CBR (Auto) refresh and self refresh
- All DQs have $10\ \Omega \pm 10\%$ of series resistor
- Single 3.3 V ± 0.3 V power supply
- LVTTTL compatible
- 4,096 refresh cycles/64 ms
- Burst termination by Burst Stop command and Precharge command
- 168-pin dual in-line memory module (Pin pitch = 1.27 mm)
- Registered type
- Serial PD

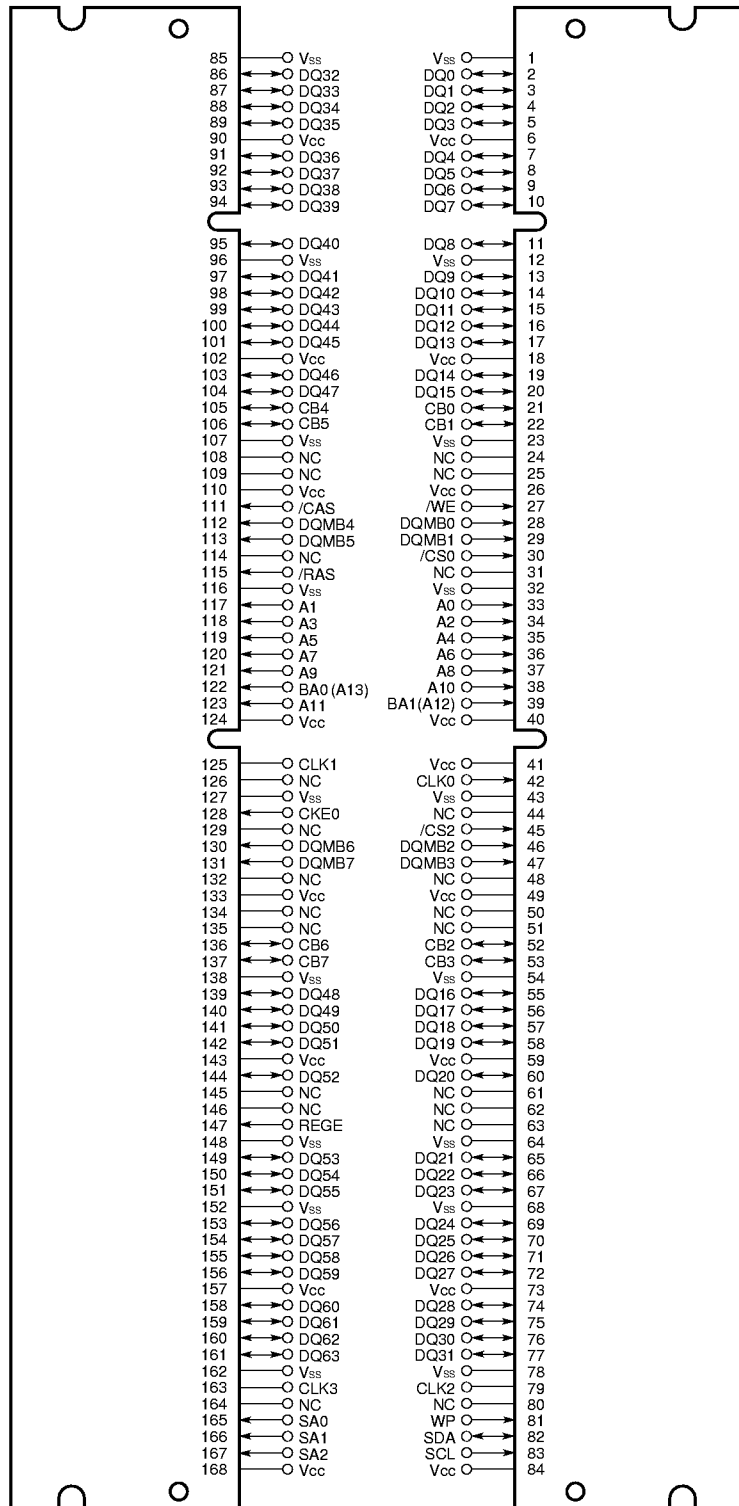
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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

Ordering Information

Part number	Clock frequency MHz (MAX.)	Package	Mounted devices
MC-4532DA726EF-A80	125 MHz	168-pin Dual In-line Memory Module	18 pieces of μ PD45128441G5 (Rev. E) (400 mil TSOP (II))
MC-4532DA726EF-A10	100 MHz	(Socket Type)	
MC-4532DA726EFB-A80	125 MHz	Edge connector: Gold plated	
MC-4532DA726EFB-A10	100 MHz	43.18 mm height	

Pin Configuration

168-pin Dual In-line Memory Module Socket Type (Edge connector: Gold plated)

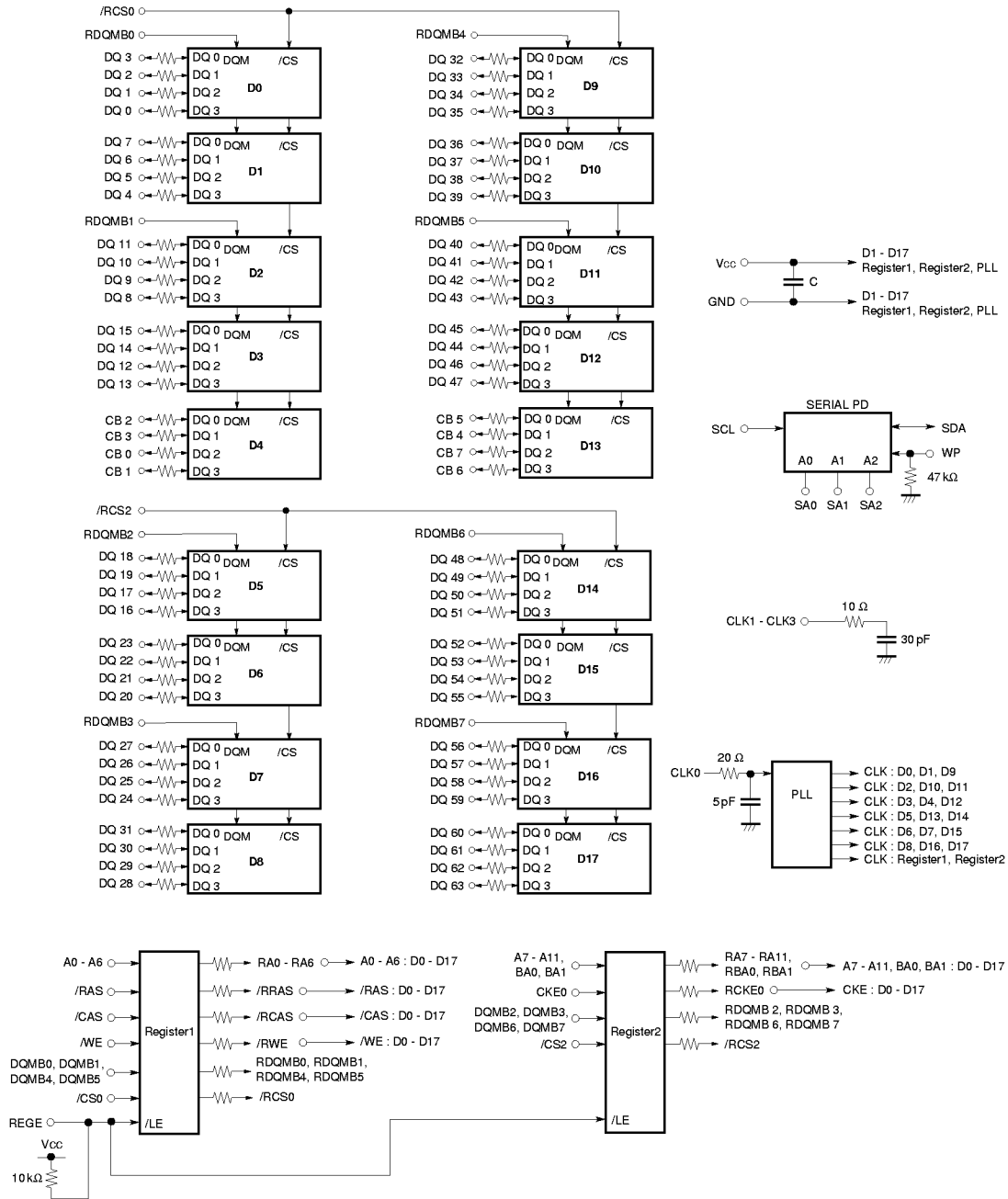


/xxx indicates active low signal.

- A0 - A11 : Address Inputs
- [Row: A0 - A11, Column: A0 - A9, A11]
- BA0 (A13), BA1 (A12) : SDRAM Bank Select
- DQ0 - DQ63, CB0 - CB7: Data Inputs/Outputs
- CLK0 - CLK3 : Clock Input
- CKE0 : Clock Enable Input
- WP : Write Protect
- /CS0, /CS2 : Chip Select Input
- /RAS : Row Address Strobe
- /CAS : Column Address Strobe
- /WE : Write Enable
- DQMB0 - DQMB7 : DQ Mask Enable
- SA0 - SA2 : Address Input for EEPROM
- SDA : Serial Data I/O for PD
- SCL : Clock Input for PD
- Vcc : Power Supply
- Vss : Ground
- REGE : Register / Buffer Enable
- NC : No Connection

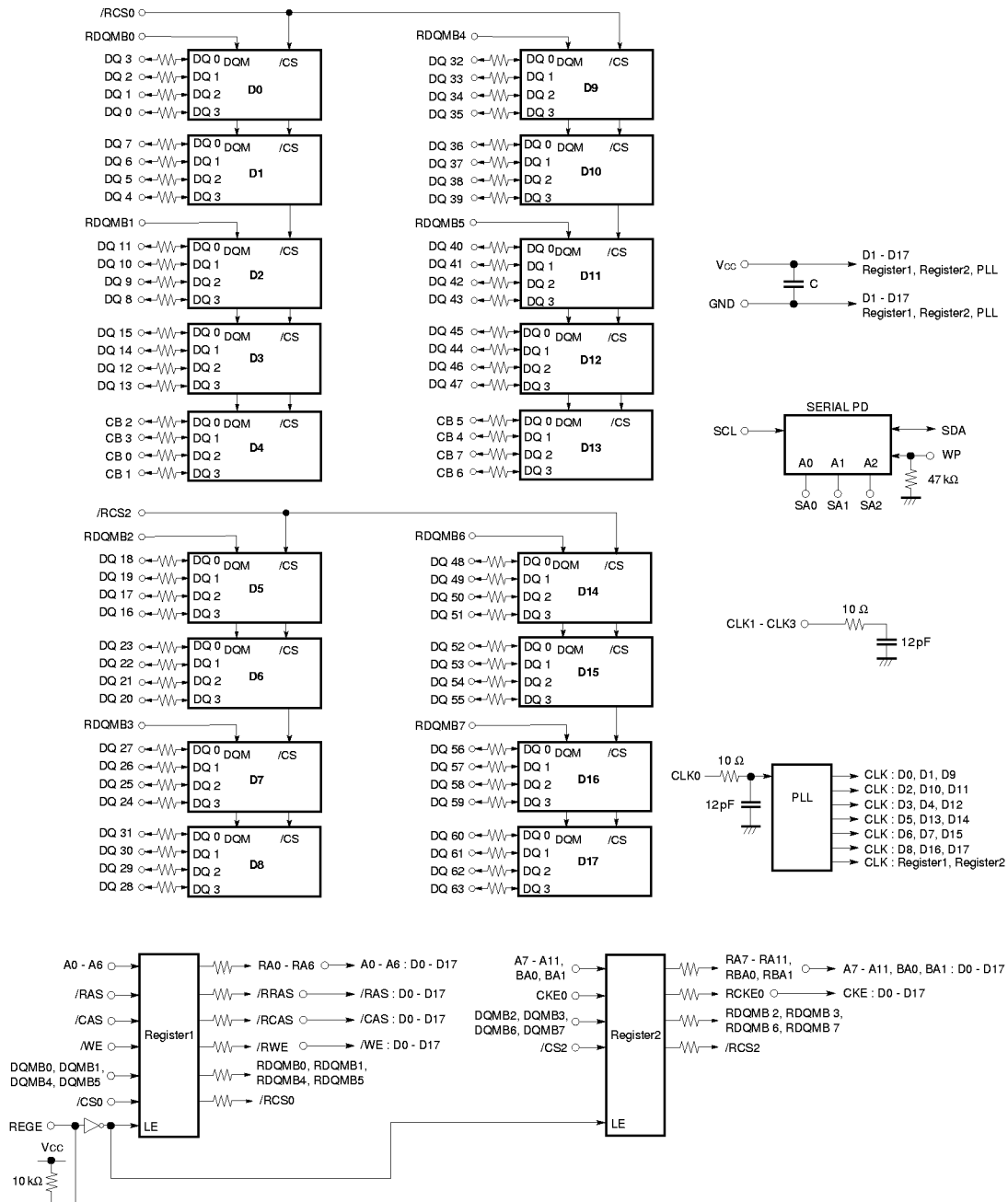
Block Diagrams

[MC-4532DA726EF]



- Remarks**
1. The value of all resistors of DQs is 10 Ω.
 2. D0 - D17: μ PD45128441 (8 M words \times 4 bits \times 4 banks)
 3. REGE \leq V_{IL}: Buffer mode
REGE \geq V_{IH}: Register mode
 4. Register: SN74ALVC16334DGG
PLL: CDC2509APW

[MC-4532DA726EFB]



- Remarks**
1. The value of all resistors of DQs is 10 Ω.
 2. D0 - D17: μ PD45128441 (8 M words \times 4 bits \times 4 banks)
 3. REGE \leq V_{IL}: Buffer mode
REGE \geq V_{IH}: Register mode
 4. Register: HD74ALVC16835
PLL: HD74CDC2509B

Electrical Specifications

- All voltages are referenced to V_{SS} (GND).
- After power up, wait more than 1 ms and then, execute power on sequence and CBR (Auto) refresh before proper device operation is achieved.

Absolute Maximum Ratings

Parameter	Symbol	Condition	Rating	Unit
Voltage on power supply pin relative to GND	V_{CC}		-0.5 to +4.6	V
Voltage on input pin relative to GND	V_{T}		-0.5 to +4.6	V
Short circuit output current	I_{O}		50	mA
Power dissipation	P_{D}		21	W
Operating ambient temperature	T_{A}		0 to +70	°C
Storage temperature	T_{stg}		-55 to +125	°C

Caution Exposing the device to stress above those listed in Absolute Maximum Ratings could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

Recommended Operating Conditions

Parameter	Symbol	Condition	MIN.	TYP.	MAX.	Unit
Supply voltage	V_{CC}		3.0	3.3	3.6	V
High level input voltage	V_{IH}		2.0		$V_{CC} + 0.3$	V
Low level input voltage	V_{IL}		-0.3		+0.8	V
Operating ambient temperature	T_{A}		0		70	°C

Capacitance (TA = 25 °C, f = 1 MHz)

[MC-4532DA726EF]

Parameter	Symbol	Test condition	MIN.	TYP.	MAX.	Unit
Input capacitance	C _{I1}	A0 - A11, BA0 (A13), BA1 (A12), /RAS, /CAS, /WE	4		10	pF
	C _{I2}	CLK0	15		35	
	C _{I3}	CKE0	8		18	
	C _{I4}	/CS0, /CS2	4		10	
	C _{I5}	DQMB0 - DQMB7	4		10	
Data input/output capacitance	C _{I/O}	DQ0 - DQ63, CB0 - CB7	6		13	pF

★ [MC-4532DA726EFB]

Parameter	Symbol	Test condition	MIN.	TYP.	MAX.	Unit
Input capacitance	C _{I1}	A0 – A11, BA0 (A13), BA1 (A12), /RAS, /CAS, /WE	4		10	pF
	C _{I2}	CLK0	15		25	
	C _{I3}	CKE0	7		20	
	C _{I4}	/CS0, /CS2	4		10	
	C _{I5}	DQMB0 - DQMB7	4		10	
Data input/output capacitance	C _{I/O}	DQ0 - DQ63, CB0 - CB7	6		13	pF

DC Characteristics (Recommended Operating Conditions unless otherwise noted)

[MC-4532DA726EF]

Parameter	Symbol	Test condition	Grade	MIN.	MAX.	Unit	Notes
Operating current	I _{CC1}	Burst length = 1 t _{RC} ≥ t _{RC (MIN.)} , I _O = 0 mA	/CAS latency = 2	-A80	2,100	mA	1
				-A10	2,100		
			/CAS latency = 3	-A80	2,100		
				-A10	2,100		
Precharge standby current in power down mode	I _{CC2P}	CKE ≤ V _{IL (MAX.)} , t _{CK} = 15 ns			268	mA	
	I _{CC2PS}	CKE ≤ V _{IL (MAX.)} , t _{CK} = ∞			29		
Precharge standby current in non power down mode	I _{CC2N}	CKE ≥ V _{IH (MIN.)} , t _{CK} = 15 ns, /CS ≥ V _{IH (MIN.)} , Input signals are changed one time during 30 ns.			610	mA	
	I _{CC2NS}	CKE ≥ V _{IH (MIN.)} , t _{CK} = ∞ , Input signals are stable.			144		
Active standby current in power down mode	I _{CC3P}	CKE ≤ V _{IL (MAX.)} , t _{CK} = 15 ns			340	mA	
	I _{CC3PS}	CKE ≤ V _{IL (MAX.)} , t _{CK} = ∞			72		
Active standby current in non power down mode	I _{CC3N}	CKE ≥ V _{IH (MIN.)} , t _{CK} = 15 ns, /CS ≥ V _{IH (MIN.)} , Input signals are changed one time during 30 ns.			790	mA	
	I _{CC3NS}	CKE ≥ V _{IH (MIN.)} , t _{CK} = ∞ , Input signals are stable.			360		
Operating current (Burst mode)	I _{CC4}	t _{CK} ≥ t _{CK (MIN.)} , I _O = 0 mA	/CAS latency = 2	-A80	2,190	mA	2
				-A10	1,830		
			/CAS latency = 3	-A80	2,640		
				-A10	2,280		
CBR (Auto) Refresh current	I _{CC5}	t _{RC} ≥ t _{RC (MIN.)}	/CAS latency = 2	-A80	4,260	mA	3
				-A10	4,260		
			/CAS latency = 3	-A80	4,260		
				-A10	4,260		
Self refresh current	I _{CC6}	CKE ≤ 0.2 V			286	mA	
Input leakage current	I _{I (L)}	V _I = 0 to 3.6 V, All other pins not under test = 0 V		-10	+10	μA	
Output leakage current	I _{O (L)}	D _{OUT} is disabled, V _O = 0 to 3.6 V		-1.5	+1.5	μA	
High level output voltage	V _{OH}	I _O = -4.0 mA		2.4		V	
Low level output voltage	V _{OL}	I _O = +4.0 mA			0.4	V	

- Notes**
- I_{CC1} depends on output loading and cycle rates. Specified values are obtained with the output open. In addition to this, I_{CC1} is measured on condition that addresses are changed only one time during t_{CK (MIN.)}.
 - I_{CC4} depends on output loading and cycle rates. Specified values are obtained with the output open. In addition to this, I_{CC4} is measured on condition that addresses are changed only one time during t_{CK (MIN.)}.
 - I_{CC5} is measured on condition that addresses are changed only one time during t_{CK (MIN.)}.

[MC-4532DA726EFB]

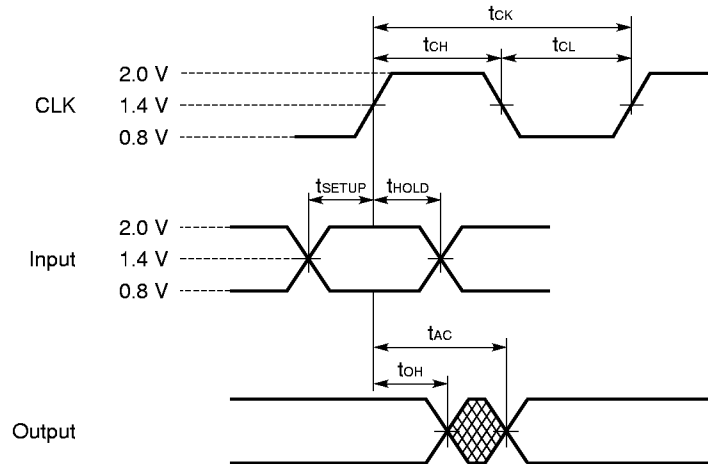
Parameter	Symbol	Test condition	Grade	MIN.	MAX.	Unit	Notes
Operating current	I _{CC1}	Burst length = 1 t _{RC} ≥ t _{RC(MIN.)} , I _O = 0 mA	/CAS latency = 2	-A80	2,100	mA	1
				-A10	2,100		
			/CAS latency = 3	-A80	2,100		
				-A10	2,100		
Precharge standby current in power down mode	I _{CC2P}	CKE ≤ V _{IL(MAX.)} , t _{CK} = 15 ns			268	mA	
	I _{CC2PS}	CKE ≤ V _{IL(MAX.)} , t _{CK} = ∞			86		
Precharge standby current in non power down mode	I _{CC2N}	CKE ≥ V _{IH(MIN.)} , t _{CK} = 15 ns, /CS ≥ V _{IH(MIN.)} , Input signals are changed one time during 30 ns.			610	mA	
	I _{CC2NS}	CKE ≥ V _{IH(MIN.)} , t _{CK} = ∞, Input signals are stable.			224		
Active standby current in power down mode	I _{CC3P}	CKE ≤ V _{IL(MAX.)} , t _{CK} = 15 ns			340	mA	
	I _{CC3PS}	CKE ≤ V _{IL(MAX.)} , t _{CK} = ∞			132		
Active standby current in non power down mode	I _{CC3N}	CKE ≥ V _{IH(MIN.)} , t _{CK} = 15 ns, /CS ≥ V _{IH(MIN.)} , Input signals are changed one time during 30 ns.			790	mA	
	I _{CC3NS}	CKE ≥ V _{IH(MIN.)} , t _{CK} = ∞, Input signals are stable.			440		
Operating current (Burst mode)	I _{CC4}	t _{CK} ≥ t _{CK(MIN.)} , I _O = 0 mA	/CAS latency = 2	-A80	2,190	mA	2
				-A10	1,830		
			/CAS latency = 3	-A80	2,640		
				-A10	2,280		
CBR (Auto) Refresh current	I _{CC5}	t _{RC} ≥ t _{RC(MIN.)}	/CAS latency = 2	-A80	4,260	mA	3
				-A10	4,260		
			/CAS latency = 3	-A80	4,260		
				-A10	4,260		
Self refresh current	I _{CC6}	CKE ≤ 0.2 V			286	mA	
Input leakage current	I _{I(L)}	V _I = 0 to 3.6 V, All other pins not under test = 0 V		-10	+10	μA	
Input leakage current (CKE0)				-20	+20		
Output leakage current	I _{O(L)}	D _{OUT} is disabled, V _O = 0 to 3.6 V		-1.5	+1.5	μA	
High level output voltage	V _{OH}	I _O = -4.0 mA		2.4		V	
Low level output voltage	V _{OL}	I _O = +4.0 mA			0.4	V	

- Notes**
- I_{CC1} depends on output loading and cycle rates. Specified values are obtained with the output open. In addition to this, I_{CC1} is measured on condition that addresses are changed only one time during t_{CK(MIN.)}.
 - I_{CC4} depends on output loading and cycle rates. Specified values are obtained with the output open. In addition to this, I_{CC4} is measured on condition that addresses are changed only one time during t_{CK(MIN.)}.
 - I_{CC5} is measured on condition that addresses are changed only one time during t_{CK(MIN.)}.

AC Characteristics (Recommended Operating Conditions unless otherwise noted)

AC Characteristics Test Conditions

- AC measurements assume $t_r = 1$ ns.
- Reference level for measuring timing of input signals is 1.4 V. Transition times are measured between V_{IH} and V_{IL} .
- If t_r is longer than 1 ns, reference level for measuring timing of input signals is $V_{IH(MIN.)}$ and $V_{IL(MAX.)}$.
- An access time is measured at 1.4 V.

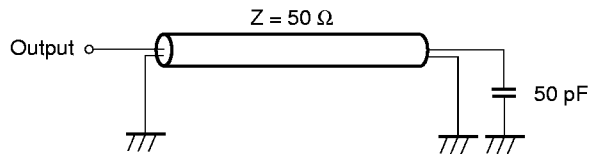


Synchronous Characteristics (Registered Mode)

[MC-4532DA726EF]

Parameter		Symbol	-A 80		-A 10		Unit	Note
			MIN.	MAX.	MIN.	MAX.		
Clock cycle time	/CAS latency = 3	t_{CK3}	8	(125 MHz)	10	(100 MHz)	ns	
	/CAS latency = 2	t_{CK2}	10	(100 MHz)	13	(77 MHz)	ns	
Access time from CLK	/CAS latency = 3	t_{AC3}		6		6	ns	1
	/CAS latency = 2	t_{AC2}		6		7	ns	1
Input CLK frequency			50	125	50	100	MHz	
Input CLK duty cycle			40	60	40	60	%	
Data-out hold time	/CAS latency = 3	t_{OH3}	3		3		ns	1
	/CAS latency = 2	t_{OH2}	3		3		ns	1
Data-out low-impedance time		t_{LZ}	0		0		ns	
Data-out high-impedance time	/CAS latency = 3	t_{HZ3}	3	6	3	6	ns	
	/CAS latency = 2	t_{HZ2}	3	6	3	7	ns	
Data-in setup time		t_{DS}	2		2		ns	
Data-in hold time		t_{DH}	1		1		ns	
Address setup time		t_{AS}	1.5		1.5		ns	
Address hold time		t_{AH}	0.9		0.9		ns	
CKE setup time		t_{CKS}	1.5		1.5		ns	
CKE hold time		t_{CKH}	0.9		0.9		ns	
CKE setup time (Power down exit)		t_{CKSP}	1.5		1.5		ns	
Command (/CS0, /CS2, /RAS, /CAS, /WE, DQMB0 - DQMB7) setup time		t_{CMS}	1.5		1.5		ns	
Command (/CS0, /CS2, /RAS, /CAS, /WE, DQMB0 - DQMB7) hold time		t_{CMH}	0.9		0.9		ns	

★ **Note 1.** Output load

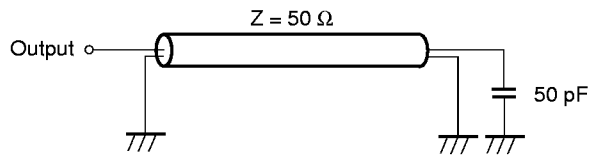


Remark These specifications are applied to the monolithic device.

[MC-4532DA726EFB]

Parameter		Symbol	-A 80		-A 10		Unit	Note
			MIN.	MAX.	MIN.	MAX.		
Clock cycle time	/CAS latency = 3	t_{CK3}	8	(125 MHz)	10	(100 MHz)	ns	
	/CAS latency = 2	t_{CK2}	10	(100 MHz)	13	(77 MHz)	ns	
Access time from CLK	/CAS latency = 3	t_{AC3}		6		6	ns	1
	/CAS latency = 2	t_{AC2}		6		7	ns	1
Input CLK frequency			50	125	50	100	MHz	
Input CLK duty cycle			40	60	40	60	%	
Data-out hold time	/CAS latency = 3	t_{OH3}	3		3		ns	1
	/CAS latency = 2	t_{OH2}	3		3		ns	1
Data-out low-impedance time		t_{LZ}	0		0		ns	
Data-out high-impedance time	/CAS latency = 3	t_{HZ3}	3	6	3	6	ns	
	/CAS latency = 2	t_{HZ2}	3	6	3	7	ns	
Data-in setup time		t_{DS}	2		2		ns	
Data-in hold time		t_{DH}	1		1		ns	
Address setup time		t_{AS}	2		2		ns	
Address hold time		t_{AH}	1		1		ns	
CKE setup time		t_{CKS}	2		2		ns	
CKE hold time		t_{CKH}	1		1		ns	
CKE setup time (Power down exit)		t_{CKSP}	2		2		ns	
Command (/CS0, /CS2, /RAS, /CAS, /WE, DQMB0 - DQMB7) setup time		t_{CMS}	2		2		ns	
Command (/CS0, /CS2, /RAS, /CAS, /WE, DQMB0 - DQMB7) hold time		t_{CMH}	1		1		ns	

★ **Note 1.** Output load



Remark These specifications are applied to the monolithic device.

Asynchronous Characteristics (Registered Mode)

Parameter	Symbol	-A80		-A10		Unit	Note
		MIN.	MAX.	MIN.	MAX.		
ACT to REF/ACT command period (Operation)	t _{RC}	70		70		ns	
REF to REF/ACT command period (Refresh)	t _{RC1}	70		78		ns	
ACT to PRE command period	t _{RAS}	48	120,000	50	120,000	ns	
PRE to ACT command period	t _{RP}	20		20		ns	
Delay time ACT to READ/WRITE command	t _{RCD}	20		20		ns	
ACT(0) to ACT(1) command period	t _{RRD}	16		20		ns	
Data-in to PRE command period	t _{DPL}	-1CLK+8		-1CLK+10		ns	
Data-in to ACT(REF) command period (Auto precharge)	/CAS latency = 3	t _{DAL3}	20	20		ns	
	/CAS latency = 2	t _{DAL2}	20	20		ns	
Mode register set cycle time	t _{RSC}	2		2		CLK	
Transition time	t _T	0.5	30	1	30	ns	
Refresh time (4,096 refresh cycles)	t _{REF}		64		64	ms	

Serial PD

[MC-4532DA726EF]

(1/2)

Byte No.	Function Described	Hex	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Notes	
0	Defines the number of bytes written into serial PD memory	80H	1	0	0	0	0	0	0	0	128 bytes	
1	Total number of bytes of serial PD memory	08H	0	0	0	0	1	0	0	0	256 bytes	
2	Fundamental memory type	04H	0	0	0	0	0	1	0	0	SDRAM	
3	Number of rows	0CH	0	0	0	0	1	1	0	0	12 rows	
4	Number of columns	0BH	0	0	0	0	1	0	1	1	11 columns	
5	Number of banks	01H	0	0	0	0	0	0	0	1	1 bank	
6	Data width	48H	0	1	0	0	1	0	0	0	72 bits	
7	Data width (continued)	00H	0	0	0	0	0	0	0	0	0	
8	Voltage interface	01H	0	0	0	0	0	0	0	1	LVTTTL	
9	CL = 3 Cycle time	-A80	80H	1	0	0	0	0	0	0	0	8 ns
		-A10	A0H	1	0	1	0	0	0	0	0	10 ns
10	CL = 3 Access time	-A80	60H	0	1	1	0	0	0	0	0	6 ns
		-A10	60H	0	1	1	0	0	0	0	0	6 ns
11	DIMM configuration type	02H	0	0	0	0	0	0	1	0	ECC	
12	Refresh rate/type	80H	1	0	0	0	0	0	0	0	Normal	
13	SDRAM width	04H	0	0	0	0	0	1	0	0	×4	
14	Error checking SDRAM width	04H	0	0	0	0	0	1	0	0	×4	
15	Minimum clock delay	01H	0	0	0	0	0	0	0	1	1 clock	
16	Burst length supported	8FH	1	0	0	0	1	1	1	1	1, 2, 4, 8, F	
17	Number of banks on each SDRAM	04H	0	0	0	0	0	1	0	0	4 banks	
18	/CAS latency supported	06H	0	0	0	0	0	1	1	0	2, 3	
19	/CS latency supported	01H	0	0	0	0	0	0	0	1	0	
20	/WE latency supported	01H	0	0	0	0	0	0	0	1	0	
21	SDRAM module attributes	1FH	0	0	0	1	1	1	1	1	Registered	
22	SDRAM device attributes : General	0EH	0	0	0	0	1	1	1	0		
23	CL = 2 Cycle time	-A80	A0H	1	0	1	0	0	0	0	0	10 ns
		-A10	D0H	1	1	0	1	0	0	0	0	13 ns
24	CL = 2 Access time	-A80	60H	0	1	1	0	0	0	0	0	6 ns
		-A10	70H	0	1	1	1	0	0	0	0	7 ns
25-26		00H	0	0	0	0	0	0	0	0		
27	t _{RP(MIN.)}	-A80	14H	0	0	0	1	0	1	0	0	20 ns
		-A10	14H	0	0	0	1	0	1	0	0	20 ns
28	t _{RRD(MIN.)}	-A80	10H	0	0	0	1	0	0	0	0	16 ns
		-A10	14H	0	0	0	1	0	1	0	0	20 ns
29	t _{RCD(MIN.)}	-A80	14H	0	0	0	1	0	1	0	0	20 ns
		-A10	14H	0	0	0	1	0	1	0	0	20 ns
30	t _{RAS(MIN.)}	-A80	30H	0	0	1	1	0	0	0	0	48 ns
		-A10	32H	0	0	1	1	0	0	1	0	50 ns
31	Module bank density	40H	0	1	0	0	0	0	0	0	256M bytes	

(2/2)

Byte No.	Function Described	Hex	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Notes
32	Command and address signal input setup time	15H	0	0	0	1	0	1	0	1	1.5 ns
33	Command and address signal input hold time	09H	0	0	0	0	1	0	0	1	0.9 ns
34	Data signal input setup time	20H	0	0	1	0	0	0	0	0	2 ns
35	Data signal input hold time	10H	0	0	0	1	0	0	0	0	1 ns
36-61		00H	0	0	0	0	0	0	0	0	
62	SPD revision	12H	0	0	0	1	0	0	1	0	1.2A
★	63 Checksum for bytes 0 - 62	-A80	28H	0	0	1	0	1	0	0	
★		-A10	8EH	1	0	0	0	1	1	1	0
64-71	Manufacturer's JEDEC ID code										
72	Manufacturing location										
73-90	Manufacturer's P/N										
91	Revision Code										
93-94	Manufacturing date										
95-98	Assembly serial number										
99-125	Mfg specific										
126	Intel specification frequency	64H	0	1	1	0	0	1	0	0	100 MHz
127	Intel specification /CAS latency support	-A80	87H	1	0	0	0	0	1	1	1
		-A10	85H	1	0	0	0	0	1	0	1

[MC-4532DA726EFB]

(1/2)

Byte No.	Function Described	Hex	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Notes
0	Defines the number of bytes written into serial PD memory	80H	1	0	0	0	0	0	0	0	128 bytes
1	Total number of bytes of serial PD memory	08H	0	0	0	0	1	0	0	0	256 bytes
2	Fundamental memory type	04H	0	0	0	0	0	1	0	0	SDRAM
3	Number of rows	0CH	0	0	0	0	1	1	0	0	12 rows
4	Number of columns	0BH	0	0	0	0	1	0	1	1	11 columns
5	Number of banks	01H	0	0	0	0	0	0	0	1	1 bank
6	Data width	48H	0	1	0	0	1	0	0	0	72 bits
7	Data width (continued)	00H	0	0	0	0	0	0	0	0	0
8	Voltage interface	01H	0	0	0	0	0	0	0	1	LVTTTL
9	CL = 3 Cycle time	-A80	80H	1	0	0	0	0	0	0	8 ns
		-A10	A0H	1	0	1	0	0	0	0	10 ns
10	CL = 3 Access time	-A80	60H	0	1	1	0	0	0	0	6 ns
		-A10	60H	0	1	1	0	0	0	0	6 ns
11	DIMM configuration type	02H	0	0	0	0	0	0	1	0	ECC
12	Refresh rate/type	80H	1	0	0	0	0	0	0	0	Normal
13	SDRAM width	04H	0	0	0	0	0	1	0	0	×4
14	Error checking SDRAM width	04H	0	0	0	0	0	1	0	0	×4
15	Minimum clock delay	01H	0	0	0	0	0	0	0	1	1 clock
16	Burst length supported	8FH	1	0	0	0	1	1	1	1	1, 2, 4, 8, F
17	Number of banks on each SDRAM	04H	0	0	0	0	0	1	0	0	4 banks
18	/CAS latency supported	06H	0	0	0	0	0	1	1	0	2, 3
19	/CS latency supported	01H	0	0	0	0	0	0	0	1	0
20	/WE latency supported	01H	0	0	0	0	0	0	0	1	0
21	SDRAM module attributes	1FH	0	0	0	1	1	1	1	1	Registered
22	SDRAM device attributes : General	0EH	0	0	0	0	1	1	1	0	
23	CL = 2 Cycle time	-A80	A0H	1	0	1	0	0	0	0	10 ns
		-A10	D0H	1	1	0	1	0	0	0	13 ns
24	CL = 2 Access time	-A80	60H	0	1	1	0	0	0	0	6 ns
		-A10	70H	0	1	1	1	0	0	0	7 ns
25-26		00H	0	0	0	0	0	0	0	0	
27	t _{RP(MIN.)}	-A80	14H	0	0	0	1	0	1	0	20 ns
		-A10	14H	0	0	0	1	0	1	0	20 ns
28	t _{RRD(MIN.)}	-A80	10H	0	0	0	1	0	0	0	16 ns
		-A10	14H	0	0	0	1	0	1	0	20 ns
29	t _{RCD(MIN.)}	-A80	14H	0	0	0	1	0	1	0	20 ns
		-A10	14H	0	0	0	1	0	1	0	20 ns
30	t _{RAS(MIN.)}	-A80	30H	0	0	1	1	0	0	0	48 ns
		-A10	32H	0	0	1	1	0	0	1	50 ns
31	Module bank density	40H	0	1	0	0	0	0	0	0	256M bytes

(2/2)

Byte No.	Function Described	Hex	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Notes	
32	Command and address signal input setup time	20H	0	0	1	0	0	0	0	0	2 ns	
33	Command and address signal input hold time	10H	0	0	0	1	0	0	0	0	1 ns	
34	Data signal input setup time	20H	0	0	1	0	0	0	0	0	2 ns	
35	Data signal input hold time	10H	0	0	0	1	0	0	0	0	1 ns	
36-61		00H	0	0	0	0	0	0	0	0		
62	SPD revision	12H	0	0	0	1	0	0	1	0	1.2A	
63	Checksum for bytes 0 - 62	-A80	3AH	0	0	1	1	1	0	1	0	
		-A10	A0H	1	0	1	0	0	0	0	0	
64-71	Manufacture's JEDEC ID code											
72	Manufacturing location											
73-90	Manufacture's P/N											
91	Revision Code											
93-94	Manufacturing date											
95-98	Assembly serial number											
99-125	Mfg specific											
126	Intel specification frequency	64H	0	1	1	0	0	1	0	0	100 MHz	
127	Intel specification /CAS latency support	-A80	87H	1	0	0	0	0	1	1	1	
		-A10	85H	1	0	0	0	0	1	0	1	

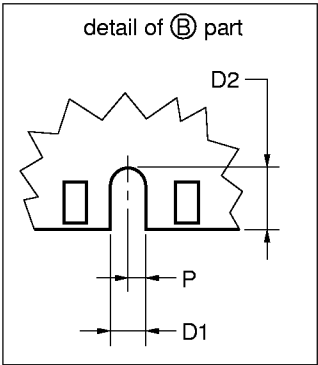
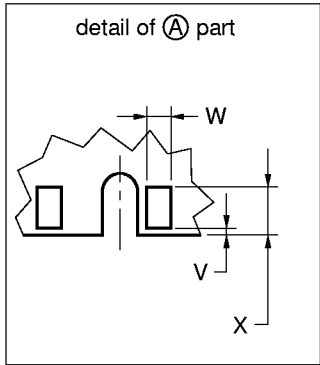
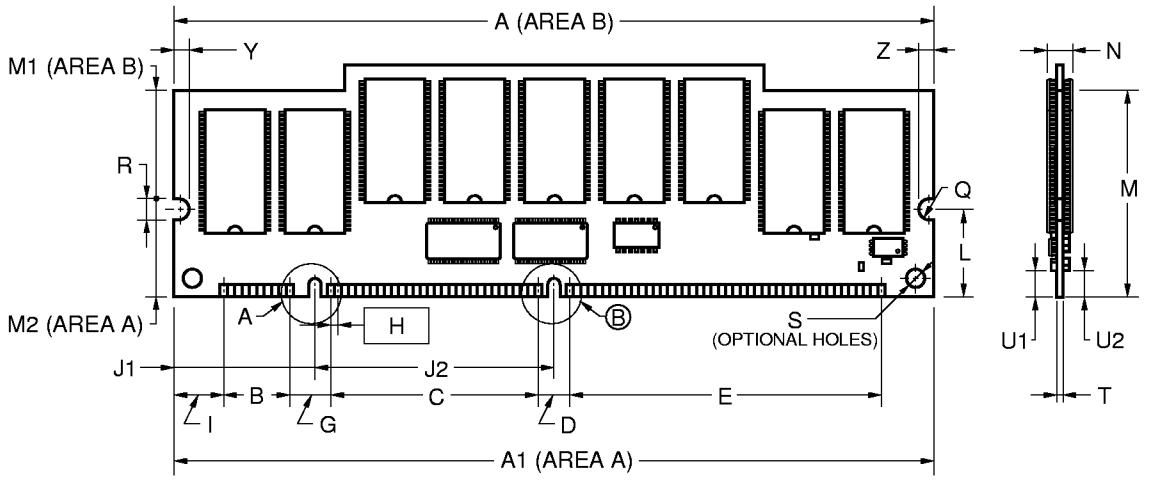
Timing Chart

Refer to the **SYNCHRONOUS DRAM MODULE TIMING CHART Information (M13348E)**.

★ Package Drawings

[MC-4532DA726EF]

168 PIN DUAL IN-LINE MODULE (SOCKET TYPE)

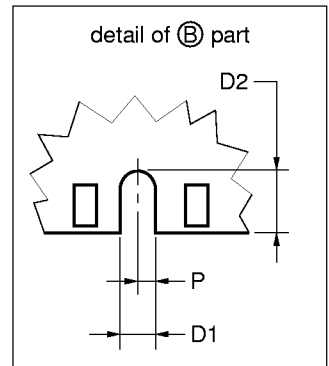
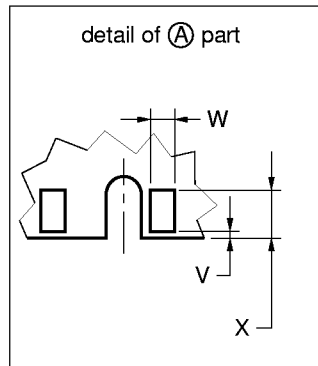
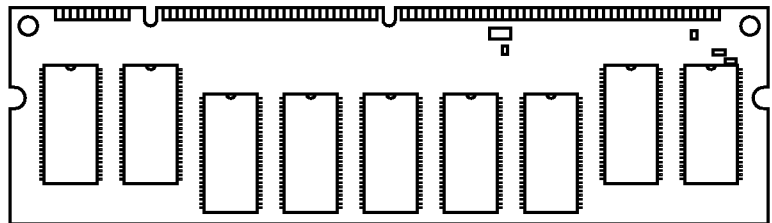
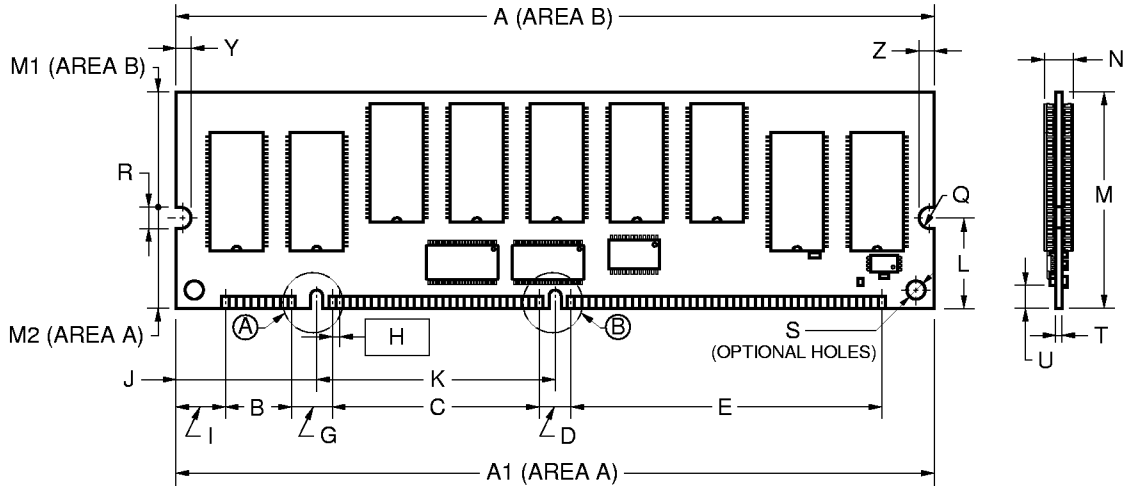


ITEM	MILLIMETERS
A	133.35
A1	133.35±0.13
B	11.43
C	36.83
D	6.35
D1	2.0
D2	3.125
E	54.61
F	5.08
G	6.35
H	1.27 (T.P.)
I	8.89
J1	24.495
J2	42.18
K1	29.97
K2	29.97
L	17.78
M	38.1±0.13
M1	18.32
M2	19.78
N	4.0 MAX.
P	1.0
Q	R2.0
R	4.0±0.10
S	φ 3.0
T	1.27±0.1
U1	4.0 MIN.
U2	4.0 MIN.
V	0.25 MAX.
W	1.0±0.05
X	2.54±0.10
Y	3.0 MIN.
Z	3.0 MIN.

M168S-50A93

[MC-4532DA726EFB]

168-PIN DUAL IN-LINE MODULE (SOCKET TYPE)



ITEM	MILLIMETERS
A	133.35
A1	133.35±0.13
B	11.43
C	36.83
D	6.35
D1	2.0
D2	3.125
E	54.61
G	6.35
H	1.27 (T.P.)
I	8.89
J	24.495
K	42.18
L	17.78
M	43.18±0.13
M1	23.40
M2	19.78
N	4.0 MAX.
P	1.0
Q	R2.0
R	4.0±0.10
S	φ3.0
T	1.27±0.1
U	4.0 MIN.
V	0.2±0.15
W	1.0±0.05
X	2.54±0.10
Y	3.0 MIN.
Z	3.0 MIN.

M168S-50A107